

**Search Notes**

Application/Control No.

10/730,145

Examiner

Dean O. Takaoka

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
333	21A	2/22/2005	DT
333	21R	2/22/2005	DT
333	125	2/23/2005	DT
333	126	2/23/2005	DT
333	135	2/23/2005	DT
333	137	2/23/2005	DT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east attached	2/22/2005	DT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner